

<b>Search Notes</b> 				<b>Application/Control No.</b> 10/031,815 <b>Examiner</b> Pia F. Tibbits	<b>Applicant(s)/Patent under Reexamination</b> LAYDEN ET AL. <b>Art Unit</b> 2838
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>	
Class	Subclass	Date	Examiner	DATE	EXMR
324	429	2/26/2006	PT	east (interference search-att'd)	2/26/2006
320	116				PT
<b>INTERFERENCE SEARCHED</b>					
Class	Subclass	Date	Examiner		
324	429	2/26/2006	PT		
320	116				